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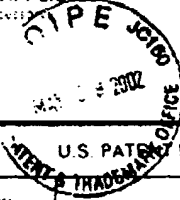
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Form PTO-1446		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-1657		SERIAL NO. 09 905.320	
LIST OF ART CITED BY APPLICANT <small>(With several sheets attached)</small>				APPLICANT: Cam Bascari et al			
				FILING DATE July 13, 2001		GROUP 1762	
							
U.S. PATENT DOCUMENTS							
Examiner's Initials	Document Number	Date	Title	Class	Subclass	Incorporated by Reference	
EF	10		1000000				
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*EXAMINER Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

8/29/01

Small Patent

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M022 1667	SERIAL NO. 166666 1234
LIST OF ART CITED BY APPLICANT <small>(To be filled in by the applicant)</small>		APPLICANT (Name, Address, etc.)	
FILING DATE 10/15/00		CLASS 166666	

U.S. PATENT DOCUMENTS

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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

CF	AR	Kim, et al. Structural and Electrical Properties of RuTe ₂ grown on p-InP (100) by low pressure metalorganic chemical vapor deposition at low temperature. Applied Physics Letters, U.S. American Institute of Physics Vol. 65, No. 15, 10/10/94, Pgs. 1955-1957
AS		
AT		

EXAMINER <i>[Signature]</i>	DATE CONSIDERED 12/15/01
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*EXAMINER: Initial or reference considered, whether or not identical to a reference with MPEP 2101. Draw the through citation if not in a reference and not considered. Include a note if the form with best construction is to be applied.

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				APP. DOCUMENT NO. SI 22 1494		SERIAL NO. 09060320	
LIST OF ART CITED BY APPLICANT <small>Use only if you have references</small>				APPLICANT <small>Applicant's Name</small>			
				FILING DATE Jan 25 2002		GROSS P. 1,000,000	
U.S. PATENT DOCUMENTS							
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OTHER REFERENCES (including Author, Title, Date, Patent Type, Etc.)							
EF	AR		S. Yamashita et al., Abstract, <i>Ra = 5-7, ratio dependency of the dielectric properties for the side (110) thin films prepared by ion beam sputtering</i> , 6th ANNUAL PHYSICS LETTERS, No. 14, pp. 1642-1646 (1994).				
EF	AN		M. Yamashita et al., Abstract, <i>Thermal-Deposition Spectroscopy of (Ba,Sr)TiO₃ Thin Films Prepared by Chemical Vapor Deposition</i> , 32 JIN. J. ON APL. PHYS. Pt. 1, No. 25, pp. 729-732 (1996).				
EF	AT		Arai T. et al., <i>Deposition of SrTiO₃ Films on Si(111)Wet by Chemical Vapor Deposition</i> , 14p. Journal of Applied Physics, Vol. 35, No. 9B, Part 01, 1994, pp. 4874-4876.				
EXAMINER				DATE CONSIDERED			
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EXAMINER: Initial of reference considered, whether or not a reference is in compliance with MPEP 609. Draw line through citation of reference and not considered. (Indicate with "X" if not in compliance with MPEP 609.)							

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ACTY. DOCKET NO. 0022-167		SERIAL NO. 000004220	
		APPLICANT Gen Resch et al.			
LIST OF ART CITED BY APPLICANT <small>(See serial sheets if necessary)</small>		FILING DATE Feb. 15, 2001		GRS. # 1-2000-01	

U.S. PATENT DOCUMENTS							
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)			
EF	AR		Takashi Kawahara et al., (Ba, SrTiO ₃) Films Prepared by Liquid Source Chemical Vapor Deposition on Ru Electrodes, 35 Jpn. J.
			APPL. PHYS. PT. 1, No. 9B, pp. 4850, 4853 (1996).
CF	AS		Rajesh Khemwani et al., A Novel Low-Temperature Process for High Dielectric Constant BST Thin Films for 1T1M DRAM
			Applications, Motorola Research Center, Univ. of Texas at Austin, TX (Undated), 2 pages.
CF	AT		Yong Tae Kim et al., Abstract, Advantages of Ru ₂ bottom electrode in the dielectric and leakage characteristics of
			(Ba, Sr)TiO ₃ capacitor, 35 Jpn. J. APPL. PHYS. PT. 1, No. 12A, pp. 6153-6156 (1996).

EXAMINER 	DATE CONSIDERED 12/05/01
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*EXAMINER: Initial if reference considered, whether or not citation is in accordance with MPEP (90). Draw line through citation if not in accordance and not considered. Include a page of this form with each submission from the applicant.

Form PTO/SB-017 AUG 29 2001		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		APP. NO. 012,167		SERIAL NO. 000,000,000	
LIST OF ART CITED BY APPLICANT (See Section 1.2 of the Manual)				APPLICANT C. S. K. K. K. K. K.			
				FILING DATE 10/15/2001		CLASS 10/15/2001	
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OTHER REFERENCES (including Author, Title, Date, Portion, Pages, Etc.)							
EF	AR	S.H. Park et al. Abstract, Characterization of MIS exposure of BSI thin films deposited on Si by RF magnetron sputtering					
		Technology, Thin Film V. Symposium, San Francisco, CA, pp. 33-39, April 7, 1995					
EF	AS	N. Takeuchi et al. Abstract, Effect of tritium atmosphere on the color hue and emission of EL, No. 100, 98-2000					
		SIAMBAK, KIRKAL GAN P. IN ROBINSON No. 5, pp. 530-539 (1990)					
EF	AT	H. Yamashita et al. Abstract, Resonance frequency method and characterization of SiO ₂ thin films, BELL					
		International Symposium on Applications of Technology, October 15, 1992, pp. 25-28, August 2, 1992					
EXAMINER					DATE CONSIDERED 12/15/01		
EXAMINER: Initial of reference considered whether or not citation is in continuance with MEIP 001. If not, then citation is not in continuance and not considered. Include copy of citation with next communication to applicant.							

7/13/01

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Sheet 1 of 1

Form PTO-1449

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PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
M1221657SERIAL NO.
UnpublishedLIST OF ART CITED BY APPLICANT
Use several sheets if necessary.APPLICANT
Com. Bacter et al.FILING DATE
7/13/01GROUP
Unpublished

U.S. PATENT DOCUMENTS

Examiner's Class	Document Number	Date	Name	Class	Success	Filing Date if Applicable
EE	AA		Com. Bacter et al. as filed			Filed Continuation
EE	AB	05/15/98	Com. Bacter et al. as filed and as amended			07/23/00
EE	AC	05/16/99	Com. Bacter et al. as filed			05/26/00
EE	AD	5/4/99	Tomczak et al.	301	321.5	
EE	AE	5/18/99	Eguchi et al.	438	785	
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FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	SubClass	Translation	
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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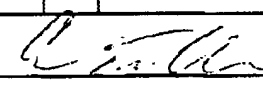
DATE CONSIDERED

12/04/01


EXAMINER: Initial if reference considered whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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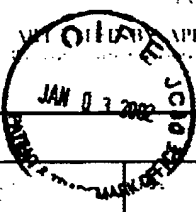
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				APP. DOCKET NO. M22-057		SERIAL NO. 10,000,000	
LIST OF ART CITED BY APPLICANT <small>(For official use only - necessary)</small>				APPLICANT Cogn. Research, Inc.			
				FILING DATE Jan. 12, 1997		CLASS 7,000,000	
U.S. PATENT DOCUMENTS							
Sequence Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Applicable
E	AA	5,276,443	10/26/93	Nakamura			
E	AB	5,731,944	01/21/97	Endo			
E	AC	5,776,294	03/24/94	Yabuta et al.			
E	AD	5,783,203	01/10/98	Yusui et al.			
E	AE	5,798,000	07/21/98	Roh			
E	AF	6,043,320	08/25/98	Hirose et al.			
E	AG	6,046,340	03/26/99	Okuma			
E	AH	6,078,402	01/01/00	Kakutani et al.			
E	AI	6,153,800	08/20/99	Hama et al.			
E	AJ	6,037,298	11/28/99	Watanabe			
E	AK	6,077,203	03/14/00	Hibi et al.			
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation Yes No
E	AL	0,855,774-A2	26/01/98	EPO - Zhao et al. Applied Materials, Inc.			
E	AM	0,937,432-A2	12/05/99	EPO - Fuda, Makihito, Mitsubishi Electric Ind. Co.			
E	AN	WO 98/09049	20/02/98	WIPO - Simpson, John et al.			
E	AO	0,474,140-A1	30/08/91	EPO - Kamiyama, Satoshi et al. NEC Corporation			
E	AP	WO 98/09045	11/06/99	WIPO - Narasaka et al. Applied Materials, Inc.			
OTHER REFERENCES (including Author, Title, Date, Page(s), Etc.)							
E	AR	Steve Bilschew et al., <i>Composition Dependence of the Deflection Properties of MOCVD Based JLTs</i> , pp. 1-21 (MRS Lab Meeting 12/01/94)					
E	AS	Steve M. Bilschew et al., <i>MOCVD Based High Density DRAM Applications</i> (Report for SEMATECH/WEST 07/12/95) 2 page.					
E	AT	Y. C. Chen et al., <i>Abstract, Improvements in the Properties of Chemical Vapor-Deposited (Ch. V. D.) Films Through Use of a Self</i> <i>Etcher</i> , 6 IN. J. APP. PHYS. Pt. 1, No. 11, pp. 6624-6628 (1997)					
EXAMINER 				DATE CONSIDERED 11/26/01			
<small>EXAMINER - Initial reference is considered whether or not it is in accordance with MPEP 609. If not, how through a search in not in accordance and not considered. The date of this report with the date of the examination.</small>							

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		APPY (JACKET) NO. M22 1657		SERIAL NO. 16,905,150			
LIST OF ART CITED BY APPLICANT <small>(For each entry, give the following information)</small>				APPLICANT <small>(Give Name and Address)</small>			
FILING DATE 12/15/01				CLASS 1-4			
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Examination Type	Document Number	Date	Name	Class	Filing Date If Applicable		
EF	5,475,396	11/28/95	Moskwa et al.				
EF	5,254,505	10/10/93	Kanagawa				
EF	6,156,033	12/18/00	Agarwal et al.				
EF	6,165,334	12/18/00	Agarwal et al.				
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OTHER REFERENCES (including Author, Title, Date, Publication Pages, Etc.)							
EF	AP		Chung-Ming Chu et al., Abstract, <i>Electronic properties and crystal structure of the SrTiO₃ films prepared at low temperatures</i>				
			in a LaNiO ₃ electrode by radio-frequency magnetron sputtering, 70 APPLIED PHYSICS LETTERS No. 2, pp. 249-251 (1997)				
EF	AN		Kazuhito Iguchi et al., Abstract, <i>Chemical vapor deposition on the Si (111) thin films on application in gas-barrier</i>				
			dynamic random access memories, 14 INTEGRATED CIRCUITS No. 1-3, Pt. 1, pp. 33-42, 1997				
EF	AI		QIN, Jie et al., Abstract, <i>Structural and electronic properties of Bi₂Se₃ thin films with an epitaxial bottom electrode</i>				
			IN INTEGRATED CIRCUITS No. 1-4, pp. 111-119, 1998				
EXAMINER			DATE CONSIDERED 12/05/01				
<small>*EXAMINER: Please refer to the enclosed, whether it is citation to a document with MPEP 609. Draw line through citation if not in your information and not considered. Include cross-reference to the cited document in the application.</small>							

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-1657		SERIAL NO. 09/905,320	
LIST OF ART CITED BY APPLICANT <small>(Use several sheets if necessary)</small>				APPLICANT: Cem Basceri et al.			
				FILING DATE July 13, 2001		GROUP 1782	
U.S. PATENT DOCUMENTS							
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EF	AA	5,504,214	01-1997	Shaw	357	200	
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EF	AC	00/344,988		Amended in pt. (filed) and amended in response to 00/2961 Office Action, 03/06/00 Office Action, and 11/29/01 Office Action		August 28, 1999	
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Form 2-1-2

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UNITED STATES DEPARTMENT OF COMMERCE BUREAU OF PATENT AND TRADEMARK OFFICE				CLASSIFICATION		REMARKS		
LIST OF ARTS (TO BE FILLED BY APPLICANT)				ARTS AND SUBJECT MATTER		REMARKS		
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